

Notice of References Cited

Application/Control No.

10/562,125

Applicant(s)/Patent Under
Reexamination
KIM ET AL.

Examiner

/Mark L. Berch/

Art Unit

1624

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Pae et al., Tetrahedron Volume 56, Issue 31, 28 July 2000, Pages 5657-5665
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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